

## Fully-Integrated, Fixed-Frequency, Low-Jitter Crystal Oscillator Clock Generator

### FEATURES

- Single 3.3-V Supply
- High-Performance Clock Generator, Incorporating Crystal Oscillator Circuitry with Integrated Frequency Synthesizer
- Low Output Jitter: As low as 380 fs (RMS integrated between 10 kHz to 20 MHz)
- Low Phase Noise at 312.5 MHz:
  - Less than  $-120$  dBc/Hz at 10 kHz and  $-147$  dBc/Hz at 10-MHz offset from carrier
- Supports Crystal or LVCMOS Input Frequencies at 31.25 MHz, 33.33 MHz, and 35.42 MHz
- Output Frequencies: 100 MHz, 106.25 MHz, 125 MHz, 156.25 MHz, 212.5 MHz, 250 MHz, and 312.5 MHz
- Differential Low-Voltage Positive Emitter Coupled Logic (LVPECL) Outputs
- Fully-Integrated Voltage-Controlled Oscillator (VCO): Runs from 1.75 GHz to 2.35 GHz
- Typical Power Consumption: 300 mW
- Chip Enable Control Pin
- Available in 4-mm x 4-mm QFN-24 Package
- ESD Protection Exceeds 2 kV (HBM)
- Industrial Temperature Range:  $-40^{\circ}\text{C}$  to  $+85^{\circ}\text{C}$

### APPLICATIONS

- Low-Cost, Low-Jitter Frequency Multiplier

### DESCRIPTION

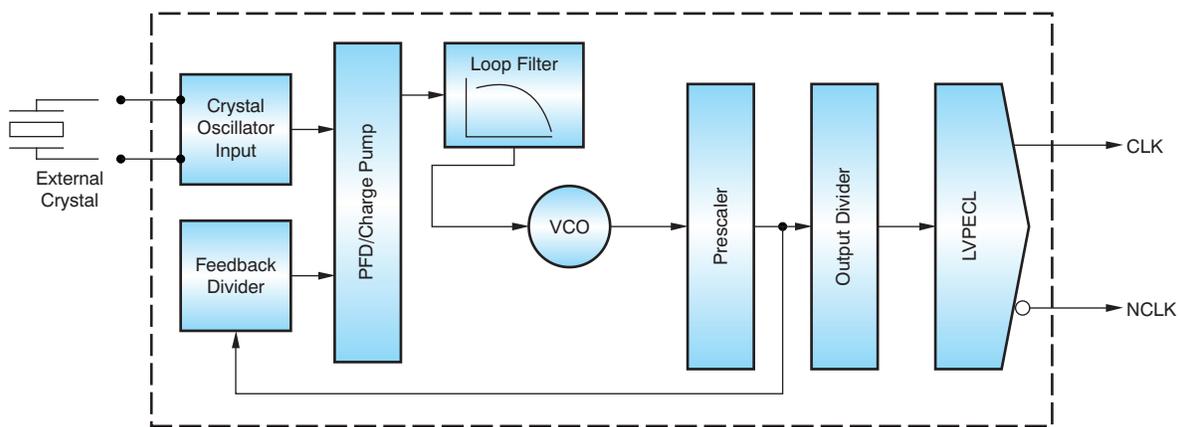
The CDC421Axxx is a high-performance, low-phase-noise clock generator. It has an integrated low-noise, LC-based voltage-controlled oscillator (VCO) that operates within the 1.75 GHz to 2.35 GHz frequency range. It has an integrated crystal oscillator that operates in conjunction with an external AT-cut crystal to produce a stable frequency reference for a phase-locked loop (PLL)-based frequency synthesizer. The output frequency ( $f_{\text{OUT}}$ ) is proportional to the frequency of the input crystal ( $f_{\text{XTAL}}$ ).

The device operates in 3.3-V supply environment and is characterized for operation from  $-40^{\circ}\text{C}$  to  $+85^{\circ}\text{C}$ . The CDC421Axxx is available in a QFN-24 4-mm x 4-mm package.

**The CDC421Axxx differs from the CDC421xxx in the following ways:**

- **Device Startup**

The CDC421Axxx has an improved startup circuit to enable correct operation for all power-supply ramp times.



**CDC421Axxx**



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

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This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

**AVAILABLE OPTIONS<sup>(1)</sup>**

| PRODUCT    | INPUT FREQUENCY OR CRYSTAL VALUE (MHz) | OUTPUT FREQUENCY FOR SPECIFIED INPUT FREQUENCY (MHz) | PACKAGE-LEAD | PACKAGE MARKING | ORDERING INFORMATION | TRANSPORT MEDIA, QUANTITY |
|------------|--|--|--------------|-----------------|----------------------|---------------------------|
| CDC421A100 | 33.3333                                | 100.00   | QFN-24       | 421A100         | CDC421A100RGET       | Tape and reel, 250        |
|            |  |  |              |                 | CDC421A100RGER       | Tape and reel, 2500       |
| CDC421A106 | 35.4167                                | 106.25   | QFN-24       | 421A106         | CDC421A106RGET       | Tape and reel, 250        |
|            |  |  |              |                 | CDC421A106RGER       | Tape and reel, 2500       |
| CDC421A125 | 31.2500                                | 125.00   | QFN-24       | 421A125         | CDC421A125RGET       | Tape and reel, 250        |
|            |  |  |              |                 | CDC421A125RGER       | Tape and reel, 2500       |
| CDC421A156 | 31.2500                                | 156.25   | QFN-24       | 421A156         | CDC421A156RGET       | Tape and reel, 250        |
|            |  |  |              |                 | CDC421A156RGER       | Tape and reel, 2500       |
| CDC421A212 | 35.4167                                | 212.50   | QFN-24       | 421A212         | CDC421A212RGET       | Tape and reel, 250        |
|            |  |  |              |                 | CDC421A212RGER       | Tape and reel, 2500       |
| CDC421A250 | 31.2500                                | 250.00   | QFN-24       | 421A250         | CDC421A250RGET       | Tape and reel, 250        |
|            |  |  |              |                 | CDC421A250RGER       | Tape and reel, 2500       |
| CDC421A312 | 31.2500                                | 312.50   | QFN-24       | 421A312         | CDC421A312RGET       | Tape and reel, 250        |
|            |  |  |              |                 | CDC421A312RGER       | Tape and reel, 2500       |

(1) For the most current specifications and package information, see the Package Option Addendum located at the end of this data sheet or refer to our web site at [www.ti.com](http://www.ti.com).

**ABSOLUTE MAXIMUM RATINGS<sup>(1)</sup>**

Over operating free-air temperature range (unless otherwise noted).

| PARAMETER        |   | CDC421Axxx                      | UNIT |
|------------------|---|---------------------------------|------|
| V <sub>CC</sub>  | Supply voltage <sup>(2)</sup>                         | -0.5 to 4.6                     | V    |
| V <sub>I</sub>   | Voltage range for all other input pins <sup>(2)</sup> | -0.5 to V <sub>CC</sub> to +0.5 | V    |
| I <sub>O</sub>   | Output current for LVPECL                             | -50                             | mA   |
| ESD              | Electrostatic discharge (HBM)                         | 2                               | kV   |
| T <sub>A</sub>   | Specified free-air temperature range (no airflow)     | -40 to +85                      | °C   |
| T <sub>J</sub>   | Maximum junction temperature                          | +125                            | °C   |
| T <sub>STG</sub> | Storage temperature range                             | -65 to +150                     | °C   |

(1) Stresses beyond those listed under *absolute maximum ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *recommended operating condition* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) All voltage values are with respect to network ground terminal.

**RECOMMENDED OPERATING CONDITIONS**

Over operating free-air temperature range (unless otherwise noted).

|                 |   | MIN | NOM  | MAX  | UNIT |
|-----------------|---|-----|------|------|------|
| V <sub>CC</sub> | Supply voltage                                | 3.0 | 3.30 | 3.60 | V    |
| T <sub>A</sub>  | Ambient temperature (no airflow, no heatsink) | -40 |      | +85  | °C   |

## ELECTRICAL CHARACTERISTICS

Over recommended operating conditions (unless otherwise noted).

| PARAMETER            | TEST CONDITIONS                    | CDC421Axxx                             |                     |                     | UNIT    |
|----------------------|------------------------------------|--|---------------------|---------------------|---------|
|                      |                                    | MIN                                    | TYP                 | MAX                 |         |
| $V_{CC}$             | Supply voltage                     | 3.00                                   | 3.30                | 3.60                | V       |
| $I_{VCC}$            | Total current                      |  | 91                  | 110                 | mA      |
| <b>LVPECL OUTPUT</b> |                                    |  |                     |                     |         |
| $f_{CLK}$            | Output frequency                   |  | 100                 | 312.5               | MHz     |
| $V_{OH}$             | LVPECL high-level output voltage   |  | $V_{CC} - 1.20$     | $V_{CC} - 0.81$     | V       |
| $V_{OL}$             | LVPECL low-level output voltage    |  | $V_{CC} - 2.17$     | $V_{CC} - 1.36$     | V       |
| $ V_{OD} $           | LVPECL differential output voltage |  | 407                 | 1076                | mV      |
| $t_R$                | Output rise time                   | 20% to 80% of $V_{OUT(PP)}$            | 230                 |                     | ps      |
| $t_F$                | Output fall time                   | 20% to 80% of $V_{OUT(PP)}$            | 230                 |                     | ps      |
|                      | Duty cycle of the output waveform  |  | 45                  | 55                  | %       |
| $t_j$                | RMS jitter                         | 10 kHz to 20 MHz                       |                     | 1                   | ps, RMS |
| <b>LVCMOS INPUT</b>  |                                    |  |                     |                     |         |
| $V_{IL, CMOS}$       | Low-level CMOS input voltage       | $V_{CC} = 3.3 V$                       |                     | $0.3 \times V_{CC}$ | V       |
| $V_{IH, CMOS}$       | High-level CMOS input voltage      | $V_{CC} = 3.3 V$                       | $0.7 \times V_{CC}$ |                     | V       |
| $I_{L, CMOS}$        | Low-level CMOS input current       | $V_{CC} = V_{CC, max}, V_{IL} = 0.0 V$ |                     | -200                | $\mu A$ |
| $I_{H, CMOS}$        | High-level CMOS input current      | $V_{CC} = V_{CC, min}, V_{IH} = 3.7 V$ |                     | 200                 | $\mu A$ |

## FUNCTIONAL BLOCK DIAGRAM

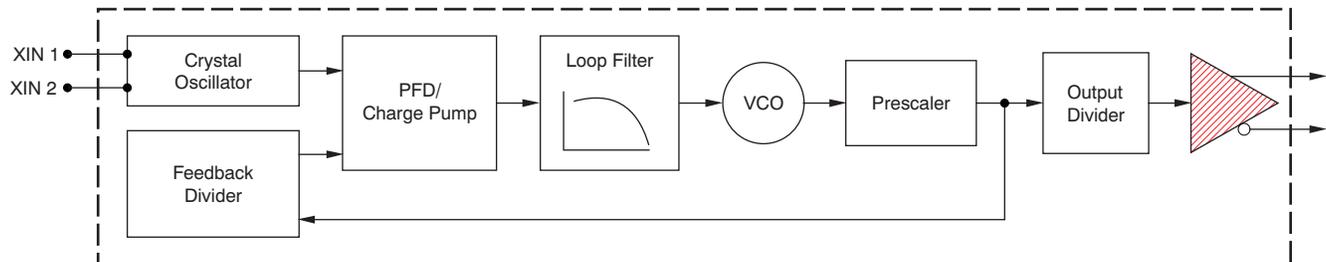
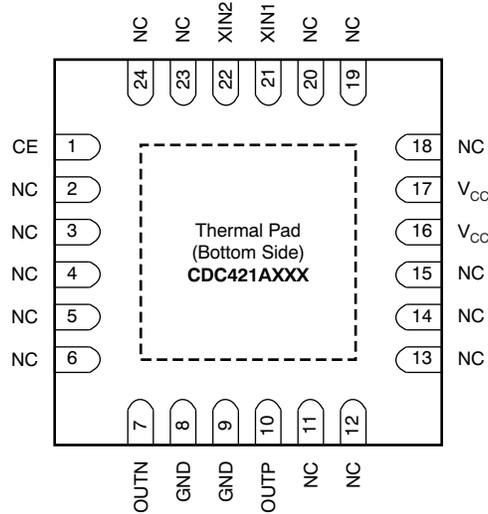


Figure 1. CDC421Axxx: High-Level Block Diagram

### DEVICE INFORMATION

**RGE PACKAGE  
QFN-24  
(TOP VIEW)**



### CDC421Axxx Pin Descriptions

| TERMINAL        |                           | TYPE   | ESD PROTECTION | DESCRIPTION   |
|-----------------|---------------------------|--------|----------------|---|
| NAME            | NO.                       |        |                |   |
| V <sub>CC</sub> | 16, 17                    | Power  | Y              | 3.3-V power supply  |
| GND             | 8, 9                      | Ground | Y              | Ground  |
| XIN1            | 21                        | I      | Y              | In crystal input mode, connect XIN1 to one end of the crystal and XIN2 to the other end of the crystal.<br>In LVC MOS single-ended driven mode, XIN1 (pin 21) acts as input reference and XIN2 should connect to GND. |
| XIN2            | 22                        | I      | N              |   |
| CE              | 1                         | I      | Y              | Chip enable (LVC MOS input)<br>CE = 1 enables the device and the outputs.<br>CE = 0 disables all current sources (LVPECLP = LVPECLN = Hi-Z).  |
| OUTP            | 10                        | O      | Y              | High-speed positive differential LVPECL output. (Outputs are enabled by CE pin.)  |
| OUTN            | 7                         | O      | Y              | High-speed negative differential LVPECL output. (Outputs are enabled by CE pin.)  |
| NC              | 2–6, 11–15, 18–20, 23, 24 | —      | Y              | TI test pin. Do not connect; leave floating.  |

### JITTER CHARACTERISTICS IN INPUT CLOCK MODE

Jitter characterization tests are performed using an LVCMOS input signal driving the CDC421Axxx device, as Figure 2 illustrates.

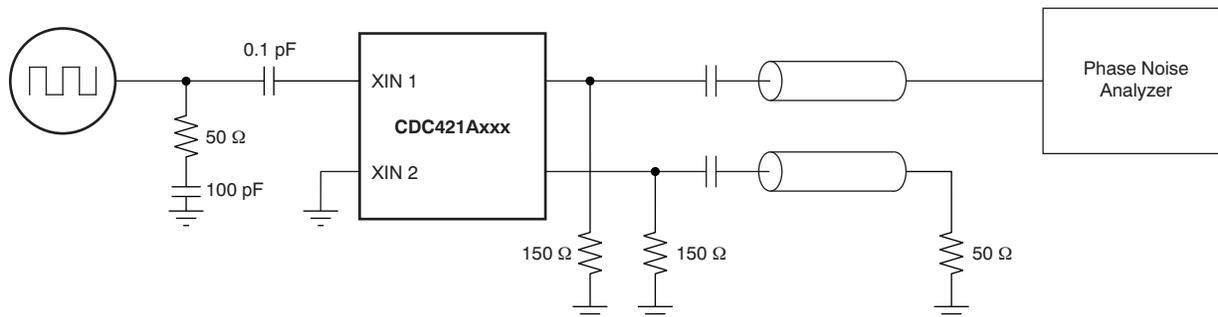


Figure 2. Jitter Test Configuration for an LVTTTL Input Driving CDC421Axxx

When the CDC421Axxx is referenced by an external, clean LVCMOS input of 31.25 MHz, 33.33 MHz, and 35.4167 MHz, Table 1 to Table 7 list the measured SSB phase noise of all the outputs supported by the CDC421Axxx device (100 MHz, 106.25 MHz, 125 MHz, 156.25 MHz, 212.5 MHz, 250 MHz, and 312.5 MHz) from 100 Hz to 20 MHz from the carrier.

Table 1. Phase Noise Data with LVCMOS Input of 33.3333 MHz and LVPECL Output at 100.00 MHz<sup>(1)</sup>

| PARAMETER           |   | MIN | TYP   | MAX | UNIT   |
|---------------------|---|-----|-------|-----|--------|
| phn <sub>100</sub>  | Phase noise at 100 Hz                       |     | -111  |     | dBc/Hz |
| phn <sub>1k</sub>   | Phase noise at 1 kHz                        |     | -121  |     | dBc/Hz |
| phn <sub>10k</sub>  | Phase noise at 10 kHz                       |     | -131  |     | dBc/Hz |
| phn <sub>100k</sub> | Phase noise at 100 kHz                      |     | -133  |     | dBc/Hz |
| phn <sub>1M</sub>   | Phase noise at 1 MHz                        |     | -142  |     | dBc/Hz |
| phn <sub>10M</sub>  | Phase noise at 10 MHz                       |     | -149  |     | dBc/Hz |
| phn <sub>20M</sub>  | Phase noise at 20 MHz                       |     | -149  |     | dBc/Hz |
| J <sub>RMS</sub>    | RMS jitter integrated from 12 kHz to 20 MHz |     | 507   |     | fs     |
| T <sub>j</sub>      | Total jitter                                |     | 35.33 |     | ps     |
| D <sub>j</sub>      | Deterministic jitter                        |     | 11.54 |     | ps     |

(1) Phase noise specifications under following conditions: input frequency = 33.3333 MHz, output frequency = 100.00 MHz.

Table 2. Phase Noise Data with LVCMOS Input of 35.4167 MHz and LVPECL Output at 106.25 MHz<sup>(1)</sup>

| PARAMETER           |   | MIN | TYP   | MAX | UNIT   |
|---------------------|---|-----|-------|-----|--------|
| phn <sub>100</sub>  | Phase noise at 100 Hz                       |     | -112  |     | dBc/Hz |
| phn <sub>1k</sub>   | Phase noise at 1 kHz                        |     | -121  |     | dBc/Hz |
| phn <sub>10k</sub>  | Phase noise at 10 kHz                       |     | -125  |     | dBc/Hz |
| phn <sub>100k</sub> | Phase noise at 100 kHz                      |     | -129  |     | dBc/Hz |
| phn <sub>1M</sub>   | Phase noise at 1 MHz                        |     | -142  |     | dBc/Hz |
| phn <sub>10M</sub>  | Phase noise at 10 MHz                       |     | -151  |     | dBc/Hz |
| phn <sub>20M</sub>  | Phase noise at 20 MHz                       |     | -151  |     | dBc/Hz |
| J <sub>RMS</sub>    | RMS jitter integrated from 12 kHz to 20 MHz |     | 530   |     | fs     |
| T <sub>j</sub>      | Total jitter                                |     | 30.39 |     | ps     |
| D <sub>j</sub>      | Deterministic jitter                        |     | 11    |     | ps     |

(1) Phase noise specifications under following conditions: input frequency = 35.4167 MHz, output frequency = 106.25 MHz.

**Table 3. Phase Noise Data with LVCMOS Input of 31.2500 MHz and LVPECL Output at 125.00 MHz<sup>(1)</sup>**

| PARAMETER           |   | MIN | TYP   | MAX | UNIT   |
|---------------------|---|-----|-------|-----|--------|
| phn <sub>100</sub>  | Phase noise at 100 Hz                       |     | -108  |     | dBc/Hz |
| phn <sub>1k</sub>   | Phase noise at 1 kHz                        |     | -118  |     | dBc/Hz |
| phn <sub>10k</sub>  | Phase noise at 10 kHz                       |     | -127  |     | dBc/Hz |
| phn <sub>100k</sub> | Phase noise at 100 kHz                      |     | -130  |     | dBc/Hz |
| phn <sub>1M</sub>   | Phase noise at 1 MHz                        |     | -139  |     | dBc/Hz |
| phn <sub>10M</sub>  | Phase noise at 10 MHz                       |     | -147  |     | dBc/Hz |
| phn <sub>20M</sub>  | Phase noise at 20 MHz                       |     | -147  |     | dBc/Hz |
| J <sub>RMS</sub>    | RMS jitter integrated from 12 kHz to 20 MHz |     | 529   |     | fs     |
| T <sub>j</sub>      | Total jitter                                |     | 47.47 |     | ps     |
| D <sub>j</sub>      | Deterministic jitter                        |     | 25.2  |     | ps     |

(1) Phase noise specifications under following conditions: input frequency = 31.2500 MHz, output frequency = 125.00 MHz.

**Table 4. Phase Noise Data with LVCMOS Input of 31.2500 MHz and LVPECL Output at 156.25 MHz<sup>(1)</sup>**

| PARAMETER           |   | MIN | TYP   | MAX | UNIT   |
|---------------------|---|-----|-------|-----|--------|
| phn <sub>100</sub>  | Phase noise at 100 Hz                       |     | -106  |     | dBc/Hz |
| phn <sub>1k</sub>   | Phase noise at 1 kHz                        |     | -117  |     | dBc/Hz |
| phn <sub>10k</sub>  | Phase noise at 10 kHz                       |     | -126  |     | dBc/Hz |
| phn <sub>100k</sub> | Phase noise at 100 kHz                      |     | -128  |     | dBc/Hz |
| phn <sub>1M</sub>   | Phase noise at 1 MHz                        |     | -139  |     | dBc/Hz |
| phn <sub>10M</sub>  | Phase noise at 10 MHz                       |     | -147  |     | dBc/Hz |
| phn <sub>20M</sub>  | Phase noise at 20 MHz                       |     | -147  |     | dBc/Hz |
| J <sub>RMS</sub>    | RMS jitter integrated from 12 kHz to 20 MHz |     | 472   |     | fs     |
| T <sub>j</sub>      | Total jitter                                |     | 31.54 |     | ps     |
| D <sub>j</sub>      | Deterministic jitter                        |     | 9.12  |     | ps     |

(1) Phase noise specifications under following conditions: input frequency = 31.2500 MHz, output frequency = 156.25 MHz.

**Table 5. Phase Noise Data with LVCMOS Input of 35.4167 MHz and LVPECL Output at 212.50 MHz<sup>(1)</sup>**

| PARAMETER           |   | MIN | TYP   | MAX | UNIT   |
|---------------------|---|-----|-------|-----|--------|
| phn <sub>100</sub>  | Phase noise at 100 Hz                       |     | -105  |     | dBc/Hz |
| phn <sub>1k</sub>   | Phase noise at 1 kHz                        |     | -115  |     | dBc/Hz |
| phn <sub>10k</sub>  | Phase noise at 10 kHz                       |     | -119  |     | dBc/Hz |
| phn <sub>100k</sub> | Phase noise at 100 kHz                      |     | -123  |     | dBc/Hz |
| phn <sub>1M</sub>   | Phase noise at 1 MHz                        |     | -135  |     | dBc/Hz |
| phn <sub>10M</sub>  | Phase noise at 10 MHz                       |     | -148  |     | dBc/Hz |
| phn <sub>20M</sub>  | Phase noise at 20 MHz                       |     | -148  |     | dBc/Hz |
| J <sub>RMS</sub>    | RMS jitter integrated from 12 kHz to 20 MHz |     | 512   |     | fs     |
| T <sub>j</sub>      | Total jitter                                |     | 33.96 |     | ps     |
| D <sub>j</sub>      | Deterministic jitter                        |     | 13.78 |     | ps     |

(1) Phase noise specifications under following conditions: input frequency = 35.4167 MHz, output frequency = 212.50 MHz.

**Table 6. Phase Noise Data with LVCMOS Input of 31.2500 MHz and LVPECL Output at 250.00 MHz<sup>(1)</sup>**

| PARAMETER           |   | MIN | TYP   | MAX | UNIT   |
|---------------------|---|-----|-------|-----|--------|
| phn <sub>100</sub>  | Phase noise at 100 Hz                       |     | -105  |     | dBc/Hz |
| phn <sub>1k</sub>   | Phase noise at 1 kHz                        |     | -112  |     | dBc/Hz |
| phn <sub>10k</sub>  | Phase noise at 10 kHz                       |     | -121  |     | dBc/Hz |
| phn <sub>100k</sub> | Phase noise at 100 kHz                      |     | -124  |     | dBc/Hz |
| phn <sub>1M</sub>   | Phase noise at 1 MHz                        |     | -134  |     | dBc/Hz |
| phn <sub>10M</sub>  | Phase noise at 10 MHz                       |     | -148  |     | dBc/Hz |
| phn <sub>20M</sub>  | Phase noise at 20 MHz                       |     | -149  |     | dBc/Hz |
| J <sub>RMS</sub>    | RMS jitter integrated from 12 kHz to 20 MHz |     | 420   |     | fs     |
| T <sub>j</sub>      | Total jitter                                |     | 36.98 |     | ps     |
| D <sub>j</sub>      | Deterministic jitter                        |     | 18.52 |     | ps     |

(1) Phase noise specifications under following conditions: input frequency = 31.2500 MHz, output frequency = 250.00 MHz.

**Table 7. Phase Noise Data with LVCMOS Input of 31.2500 MHz and LVPECL Output at 312.50 MHz<sup>(1)</sup>**

| PARAMETER           |   | MIN | TYP   | MAX | UNIT   |
|---------------------|---|-----|-------|-----|--------|
| phn <sub>100</sub>  | Phase noise at 100 Hz                       |     | -102  |     | dBc/Hz |
| phn <sub>1k</sub>   | Phase noise at 1 kHz                        |     | -111  |     | dBc/Hz |
| phn <sub>10k</sub>  | Phase noise at 10 kHz                       |     | -120  |     | dBc/Hz |
| phn <sub>100k</sub> | Phase noise at 100 kHz                      |     | -123  |     | dBc/Hz |
| phn <sub>1M</sub>   | Phase noise at 1 MHz                        |     | -135  |     | dBc/Hz |
| phn <sub>10M</sub>  | Phase noise at 10 MHz                       |     | -147  |     | dBc/Hz |
| phn <sub>20M</sub>  | Phase noise at 20 MHz                       |     | -147  |     | dBc/Hz |
| J <sub>RMS</sub>    | RMS jitter integrated from 12 kHz to 20 MHz |     | 378   |     | fs     |
| T <sub>j</sub>      | Total jitter                                |     | 29.82 |     | ps     |
| D <sub>j</sub>      | Deterministic jitter                        |     | 11    |     | ps     |

(1) Phase noise specifications under following conditions: input frequency = 31.2500 MHz, output frequency = 312.50 MHz.

**PACKAGING INFORMATION**

| Orderable Device | Status<br>(1) | Package Type | Package<br>Drawing | Pins | Package<br>Qty | Eco Plan<br>(2)            | Lead/Ball Finish | MSL Peak Temp<br>(3) | Op Temp (°C) | Top-Side Markings<br>(4) | Samples                 |
|------------------|---------------|--------------|--------------------|------|----------------|----------------------------|------------------|----------------------|--------------|--------------------------|-------------------------|
| CDC421A100RGER   | ACTIVE        | VQFN         | RGE                | 24   | 3000           | Green (RoHS<br>& no Sb/Br) | CU NIPDAU        | Level-2-260C-1 YEAR  | -40 to 85    | 421A<br>100              | <a href="#">Samples</a> |
| CDC421A100RGET   | ACTIVE        | VQFN         | RGE                | 24   | 250            | Green (RoHS<br>& no Sb/Br) | CU NIPDAU        | Level-2-260C-1 YEAR  | -40 to 85    | 421A<br>100              | <a href="#">Samples</a> |
| CDC421A106RGER   | ACTIVE        | VQFN         | RGE                | 24   | 3000           | Green (RoHS<br>& no Sb/Br) | CU NIPDAU        | Level-2-260C-1 YEAR  | -40 to 85    | 421A<br>106              | <a href="#">Samples</a> |
| CDC421A106RGET   | ACTIVE        | VQFN         | RGE                | 24   | 250            | Green (RoHS<br>& no Sb/Br) | CU NIPDAU        | Level-2-260C-1 YEAR  | -40 to 85    | 421A<br>106              | <a href="#">Samples</a> |
| CDC421A125RGER   | ACTIVE        | VQFN         | RGE                | 24   | 3000           | Green (RoHS<br>& no Sb/Br) | CU NIPDAU        | Level-2-260C-1 YEAR  | -40 to 85    | 421A<br>125              | <a href="#">Samples</a> |
| CDC421A125RGET   | ACTIVE        | VQFN         | RGE                | 24   | 250            | Green (RoHS<br>& no Sb/Br) | CU NIPDAU        | Level-2-260C-1 YEAR  | -55 to 125   | 421A<br>125              | <a href="#">Samples</a> |
| CDC421A156RGER   | ACTIVE        | VQFN         | RGE                | 24   | 3000           | Green (RoHS<br>& no Sb/Br) | CU NIPDAU        | Level-2-260C-1 YEAR  | -40 to 85    | 421A<br>156              | <a href="#">Samples</a> |
| CDC421A156RGET   | ACTIVE        | VQFN         | RGE                | 24   | 250            | Green (RoHS<br>& no Sb/Br) | CU NIPDAU        | Level-2-260C-1 YEAR  | -55 to 125   | 421A<br>156              | <a href="#">Samples</a> |
| CDC421A212RGER   | ACTIVE        | VQFN         | RGE                | 24   | 3000           | Green (RoHS<br>& no Sb/Br) | CU NIPDAU        | Level-2-260C-1 YEAR  | -40 to 85    | 421A<br>212              | <a href="#">Samples</a> |
| CDC421A212RGET   | ACTIVE        | VQFN         | RGE                | 24   | 250            | Green (RoHS<br>& no Sb/Br) | CU NIPDAU        | Level-2-260C-1 YEAR  | -40 to 85    | 421A<br>212              | <a href="#">Samples</a> |
| CDC421A250RGER   | ACTIVE        | VQFN         | RGE                | 24   | 3000           | Green (RoHS<br>& no Sb/Br) | CU NIPDAU        | Level-2-260C-1 YEAR  | -40 to 85    | 421A<br>250              | <a href="#">Samples</a> |
| CDC421A250RGET   | ACTIVE        | VQFN         | RGE                | 24   | 250            | Green (RoHS<br>& no Sb/Br) | CU NIPDAU        | Level-2-260C-1 YEAR  | -40 to 85    | 421A<br>250              | <a href="#">Samples</a> |
| CDC421A312RGER   | ACTIVE        | VQFN         | RGE                | 24   | 3000           | Green (RoHS<br>& no Sb/Br) | CU NIPDAU        | Level-2-260C-1 YEAR  | -40 to 85    | 421A<br>312              | <a href="#">Samples</a> |
| CDC421A312RGET   | ACTIVE        | VQFN         | RGE                | 24   | 250            | Green (RoHS<br>& no Sb/Br) | CU NIPDAU        | Level-2-260C-1 YEAR  | -40 to 85    | 421A<br>312              | <a href="#">Samples</a> |

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSELETE:** TI has discontinued the production of the device.

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

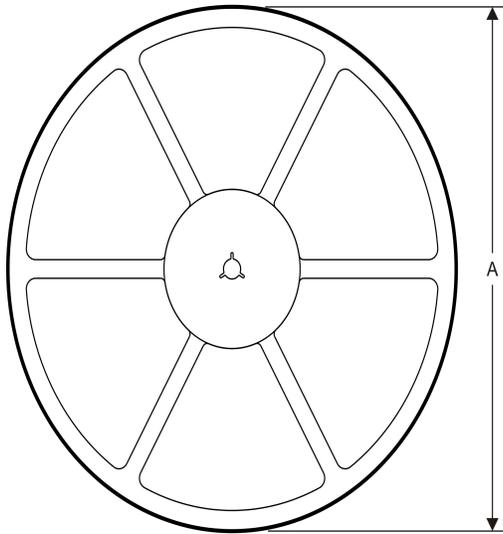
**Green (RoHS & no Sb/Br):** TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> Multiple Top-Side Markings will be inside parentheses. Only one Top-Side Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Top-Side Marking for that device.

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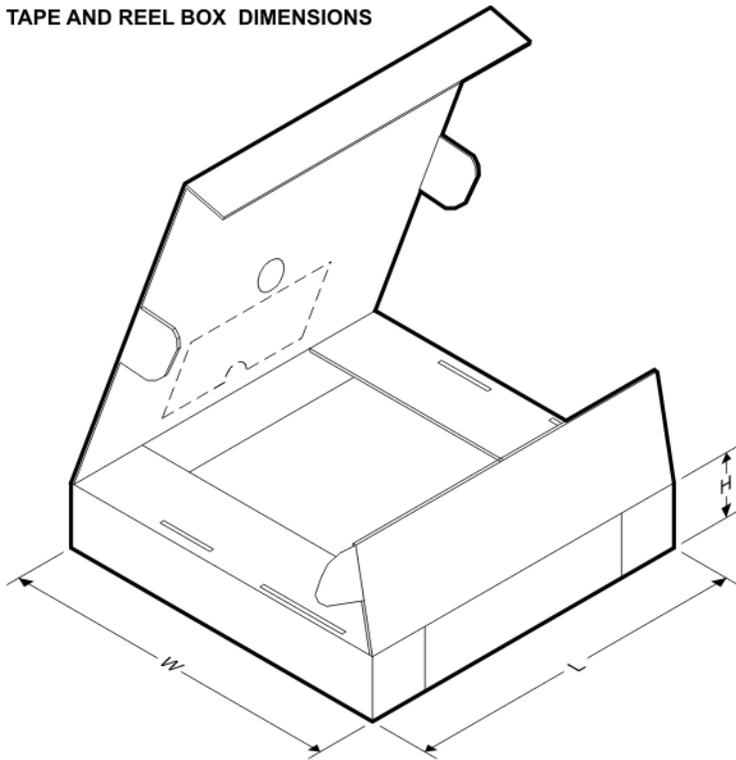
**TAPE AND REEL INFORMATION**
**REEL DIMENSIONS**

**TAPE DIMENSIONS**


|    |   |
|----|---|
| A0 | Dimension designed to accommodate the component width     |
| B0 | Dimension designed to accommodate the component length    |
| K0 | Dimension designed to accommodate the component thickness |
| W  | Overall width of the carrier tape                         |
| P1 | Pitch between successive cavity centers                   |

**TAPE AND REEL INFORMATION**

\*All dimensions are nominal

| Device         | Package Type | Package Drawing | Pins | SPQ  | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|----------------|--------------|-----------------|------|------|--------------------|--------------------|---------|---------|---------|---------|--------|---------------|
| CDC421A100RGER | VQFN         | RGE             | 24   | 3000 | 330.0              | 12.4               | 4.25    | 4.25    | 1.15    | 8.0     | 12.0   | Q2            |
| CDC421A100RGET | VQFN         | RGE             | 24   | 250  | 180.0              | 12.4               | 4.25    | 4.25    | 1.15    | 8.0     | 12.0   | Q2            |
| CDC421A106RGER | VQFN         | RGE             | 24   | 3000 | 330.0              | 12.4               | 4.25    | 4.25    | 1.15    | 8.0     | 12.0   | Q2            |
| CDC421A106RGET | VQFN         | RGE             | 24   | 250  | 180.0              | 12.4               | 4.25    | 4.25    | 1.15    | 8.0     | 12.0   | Q2            |
| CDC421A125RGER | VQFN         | RGE             | 24   | 3000 | 330.0              | 12.4               | 4.25    | 4.25    | 1.15    | 8.0     | 12.0   | Q2            |
| CDC421A125RGET | VQFN         | RGE             | 24   | 250  | 180.0              | 12.4               | 4.25    | 4.25    | 1.15    | 8.0     | 12.0   | Q2            |
| CDC421A156RGER | VQFN         | RGE             | 24   | 3000 | 330.0              | 12.4               | 4.25    | 4.25    | 1.15    | 8.0     | 12.0   | Q2            |
| CDC421A156RGET | VQFN         | RGE             | 24   | 250  | 180.0              | 12.4               | 4.25    | 4.25    | 1.15    | 8.0     | 12.0   | Q2            |
| CDC421A212RGER | VQFN         | RGE             | 24   | 3000 | 330.0              | 12.4               | 4.25    | 4.25    | 1.15    | 8.0     | 12.0   | Q2            |
| CDC421A212RGET | VQFN         | RGE             | 24   | 250  | 180.0              | 12.4               | 4.25    | 4.25    | 1.15    | 8.0     | 12.0   | Q2            |
| CDC421A250RGER | VQFN         | RGE             | 24   | 3000 | 330.0              | 12.4               | 4.25    | 4.25    | 1.15    | 8.0     | 12.0   | Q2            |
| CDC421A250RGET | VQFN         | RGE             | 24   | 250  | 180.0              | 12.4               | 4.25    | 4.25    | 1.15    | 8.0     | 12.0   | Q2            |
| CDC421A312RGER | VQFN         | RGE             | 24   | 3000 | 330.0              | 12.4               | 4.25    | 4.25    | 1.15    | 8.0     | 12.0   | Q2            |
| CDC421A312RGET | VQFN         | RGE             | 24   | 250  | 180.0              | 12.4               | 4.25    | 4.25    | 1.15    | 8.0     | 12.0   | Q2            |

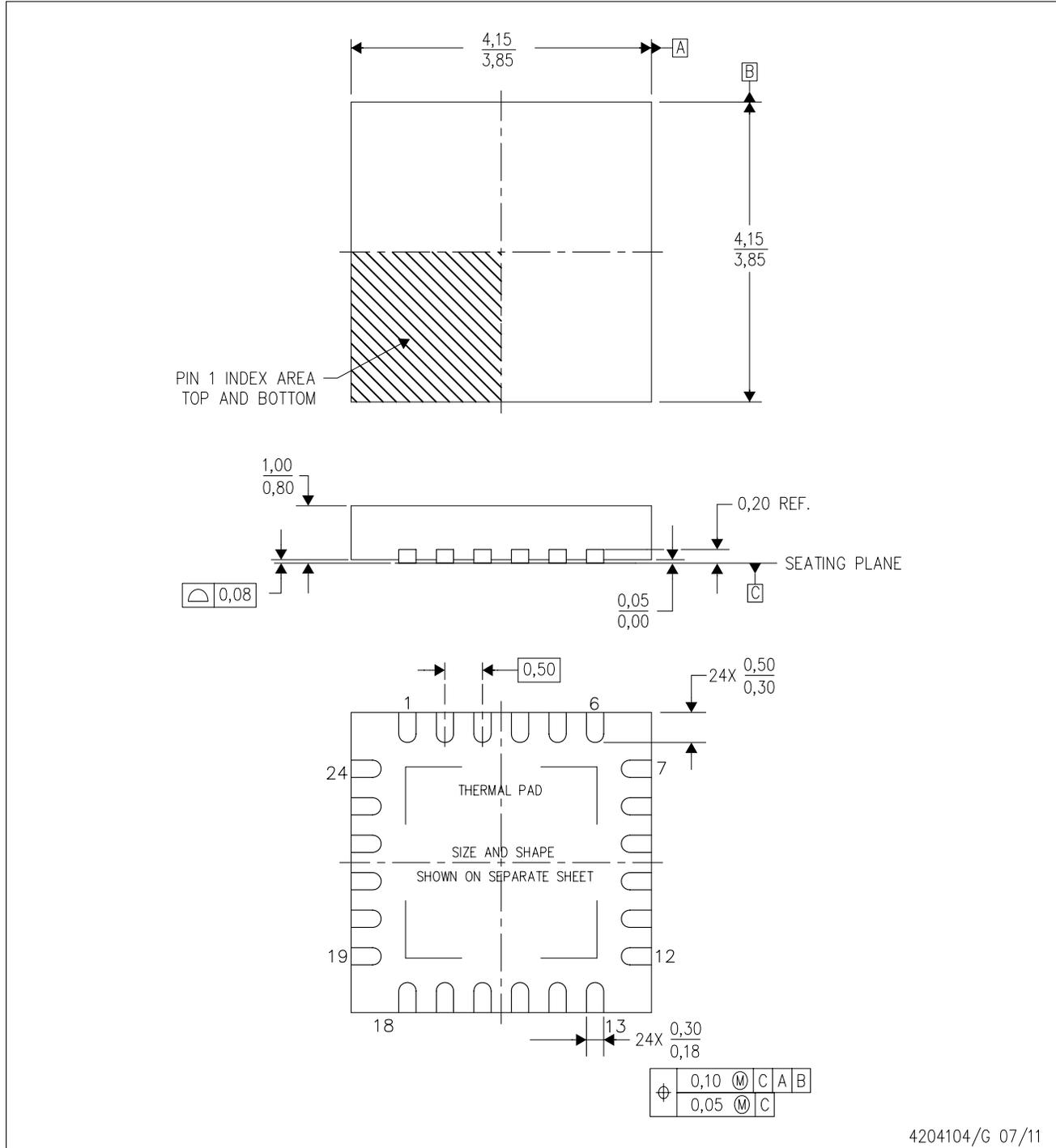
**TAPE AND REEL BOX DIMENSIONS**


\*All dimensions are nominal

| Device         | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|----------------|--------------|-----------------|------|------|-------------|------------|-------------|
| CDC421A100RGER | VQFN         | RGE             | 24   | 3000 | 367.0       | 367.0      | 35.0        |
| CDC421A100RGET | VQFN         | RGE             | 24   | 250  | 210.0       | 185.0      | 35.0        |
| CDC421A106RGER | VQFN         | RGE             | 24   | 3000 | 367.0       | 367.0      | 35.0        |
| CDC421A106RGET | VQFN         | RGE             | 24   | 250  | 210.0       | 185.0      | 35.0        |
| CDC421A125RGER | VQFN         | RGE             | 24   | 3000 | 367.0       | 367.0      | 35.0        |
| CDC421A125RGET | VQFN         | RGE             | 24   | 250  | 210.0       | 185.0      | 35.0        |
| CDC421A156RGER | VQFN         | RGE             | 24   | 3000 | 367.0       | 367.0      | 35.0        |
| CDC421A156RGET | VQFN         | RGE             | 24   | 250  | 210.0       | 185.0      | 35.0        |
| CDC421A212RGER | VQFN         | RGE             | 24   | 3000 | 367.0       | 367.0      | 35.0        |
| CDC421A212RGET | VQFN         | RGE             | 24   | 250  | 210.0       | 185.0      | 35.0        |
| CDC421A250RGER | VQFN         | RGE             | 24   | 3000 | 367.0       | 367.0      | 35.0        |
| CDC421A250RGET | VQFN         | RGE             | 24   | 250  | 210.0       | 185.0      | 35.0        |
| CDC421A312RGER | VQFN         | RGE             | 24   | 3000 | 367.0       | 367.0      | 35.0        |
| CDC421A312RGET | VQFN         | RGE             | 24   | 250  | 210.0       | 185.0      | 35.0        |

RGE (S-PVQFN-N24)

PLASTIC QUAD FLATPACK NO-LEAD



4204104/G 07/11

- NOTES:
- All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
  - This drawing is subject to change without notice.
  - Quad Flatpack, No-Leads (QFN) package configuration.
  - The package thermal pad must be soldered to the board for thermal and mechanical performance.
  - See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
  - Falls within JEDEC MO-220.

# THERMAL PAD MECHANICAL DATA

RGE (S-PVQFN-N24)

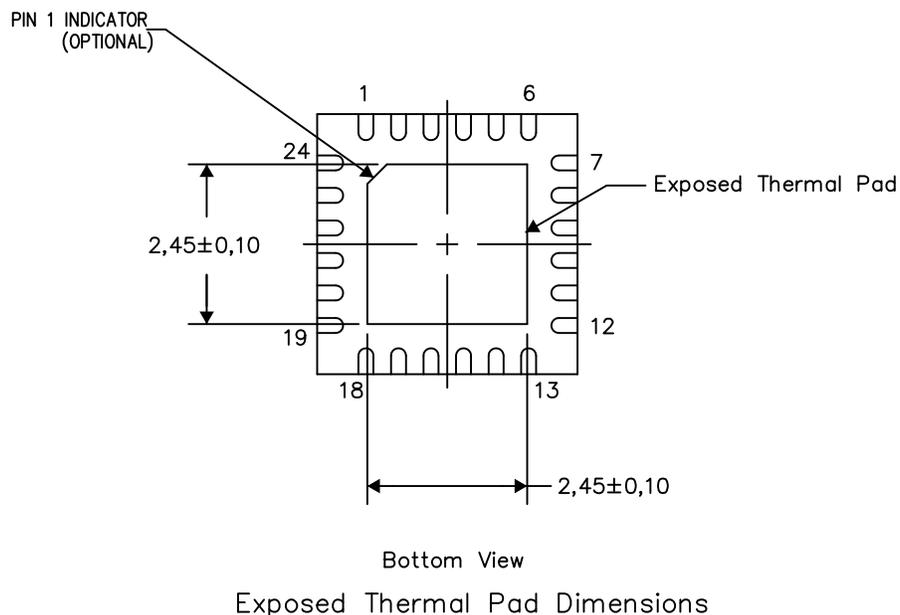
PLASTIC QUAD FLATPACK NO-LEAD

## THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at [www.ti.com](http://www.ti.com).

The exposed thermal pad dimensions for this package are shown in the following illustration.

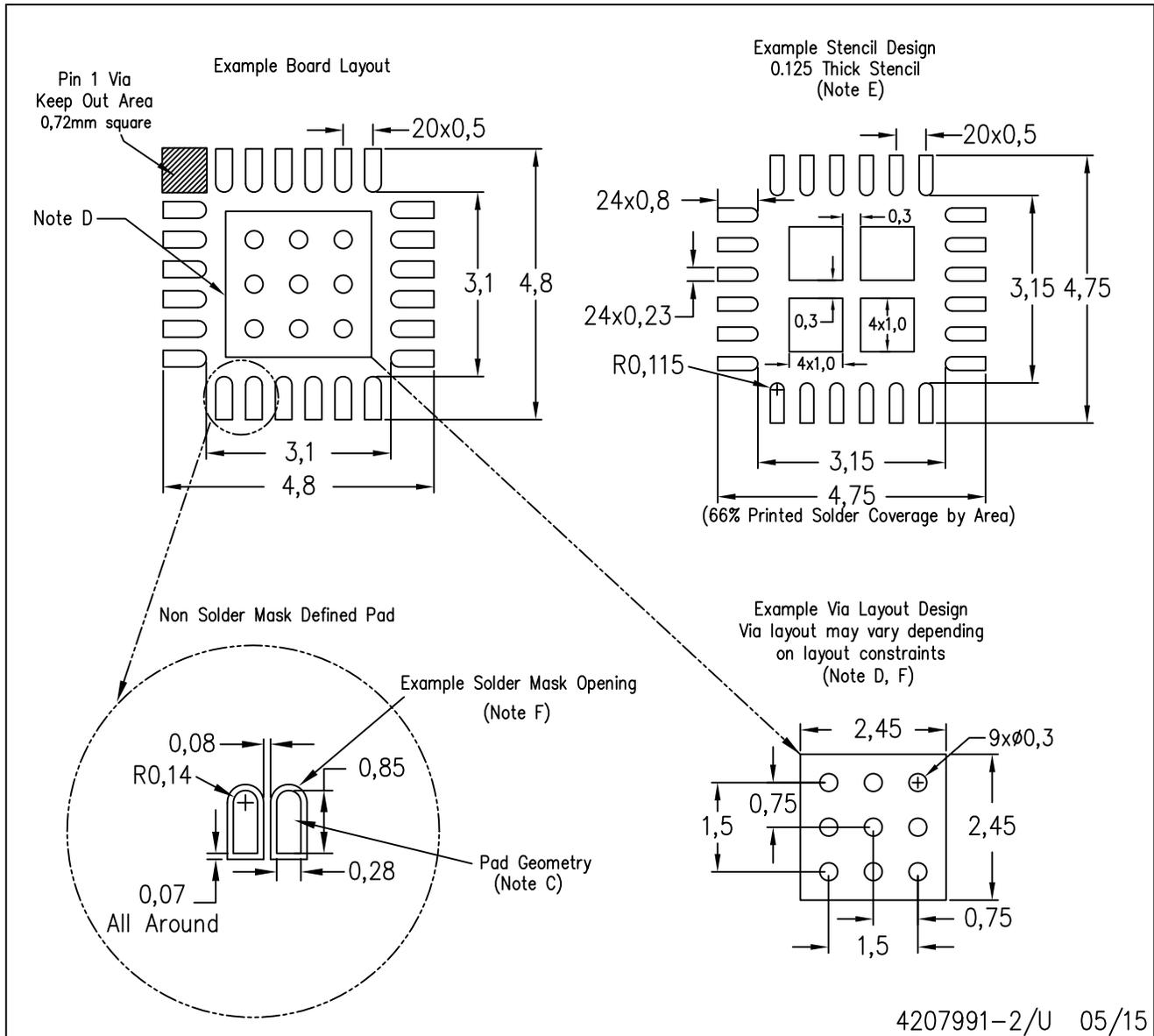


4206344-3/AK 08/15

NOTES: A. All linear dimensions are in millimeters

RGE (S-PVQFN-N24)

PLASTIC QUAD FLATPACK NO-LEAD



- NOTES:
- All linear dimensions are in millimeters.
  - This drawing is subject to change without notice.
  - Publication IPC-7351 is recommended for alternate designs.
  - This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat-Pack Packages, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at [www.ti.com](http://www.ti.com) <<http://www.ti.com>>.
  - Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
  - Customers should contact their board fabrication site for recommended solder mask tolerances and via tenting recommendations for vias placed in the thermal pad.

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